

**Notice of References Cited**

Application/Control No.

10/551,418

Applicant(s)/Patent Under  
Reexamination  
MO, SEUNG-KEE

Examiner

SEHAR MEHMOOD

Art Unit

4118

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,826,927 A	07-1974	Halfhill, Martin O.	327/126
*	B	US-3,915,151 A	10-1975	Kraus, Werner	600/13
*	C	US-4,385,339 A	05-1983	Takada et al.	361/154
*	D	US-4,875,485 A	10-1989	Matsutani, Kinya	600/415
*	E	US-4,940,453 A	07-1990	Cadwell, John A.	600/13
*	F	US-5,725,471 A	03-1998	Davey et al.	600/13
*	G	US-5,913,836 A	06-1999	Groux, Paul D.	601/21
*	H	US-5,984,854 A	11-1999	Ishikawa et al.	600/9
*	I	US-6,149,577 A	11-2000	Bouldin et al.	600/13
*	J	US-6,450,940 B1	09-2002	Moritz et al.	600/13
*	K	US-6,522,920 B2	02-2003	Silvian et al.	607/2
*	L	US-6,527,694 B1	03-2003	Ishikawa et al.	600/9
*	M	US-6,527,695 B1	03-2003	Davey et al.	600/13

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

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